## Notice of References Cited

Application/Control No. 09/437,971

Applicant(s)/Patent Under Reexamination CHEN ET AL.

Examiner

Patrick N. Edouard

Art Unit 2654

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## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,166,733	12-2000	Yamada, Tsutomu	345/776
	В	US-			
	С	US-			
	D	US-			
	Ε	US-			
	F	US-			
	G	US-			
	Н	US-			
	I	US-			
	J	US-			
	К	US-			
	L	US-			
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## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N		- "			
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## **NON-PATENT DOCUMENTS**

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